

## EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC / TIM

### Features

- Electrical features
  - $V_{DSS} = 1200\text{ V}$
  - $I_{DN} = 100\text{ A} / I_{DRM} = 200\text{ A}$
  - High current density
  - Low switching losses
- Mechanical features
  - Rugged mounting due to integrated mounting clamps
  - Integrated NTC temperature sensor
  - PressFIT contact technology
  - Pre-applied thermal interface material



Typical appearance

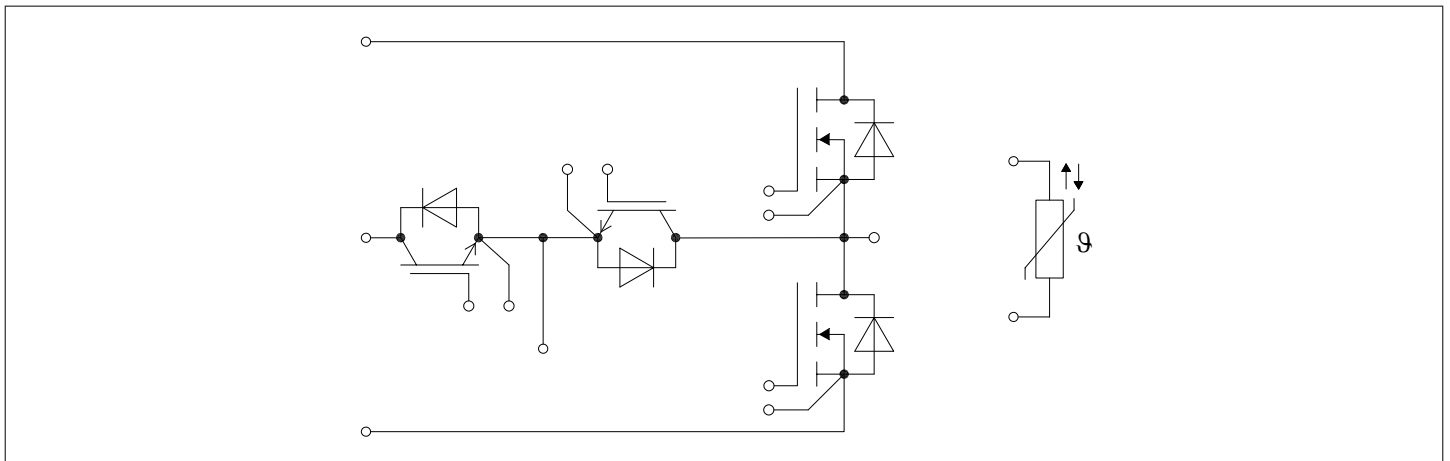
### Potential applications

- Solar applications
- Three-level applications
- DC charger for EV

### Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

### Description



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## 1 Package

**Table 1 Insulation coordination**

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	$V_{ISOL}$	RMS, $f = 50 \text{ Hz}$ , $t = 60 \text{ s}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	$Al_2O_3$	
Creepage distance	$d_{Creep}$	terminal to heatsink	11.5	mm
Creepage distance	$d_{Creep}$	terminal to terminal	6.3	mm
Clearance	$d_{Clear}$	terminal to heatsink	10.0	mm
Clearance	$d_{Clear}$	terminal to terminal	5.0	mm
Comparative tracking index	$CTI$		>200	
Relative thermal index (electrical)	$RTI$	housing	140	°C

**Table 2 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	$L_{SCE}$			12		nH
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25^\circ\text{C}$ , per switch		0.4		mΩ
Storage temperature	$T_{stg}$		-40		125	°C
Maximum baseplate operation temperature	$T_{BPmax}$				125	°C
Mounting force per clamp	$F$		40		80	N
Weight	$G$			39		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.  
Storage and shipment of modules with TIM => see AN2012-07.

## 2 MOSFET

**Table 3 Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
Drain-source voltage	$V_{DSS}$	$T_{vj} = 25^\circ\text{C}$	1200	V
Implemented drain current	$I_{DN}$		100	A
Continuous DC drain current	$I_{DDC}$	$T_{vj} = 175^\circ\text{C}$ , $V_{GS} = 18 \text{ V}$ $T_H = 65^\circ\text{C}$	85	A
Repetitive peak drain current	$I_{DRM}$	verified by design, $t_p$ limited by $T_{vjmax}$	200	A

(table continues...)

**Table 3 (continued) Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
Gate-source voltage, max. transient voltage	$V_{GS}$	$D < 0.01$	-10/23	V
Gate-source voltage, max. static voltage	$V_{GS}$		-7/20	V

**Table 4 Recommended values**

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

**Table 5 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 100\text{ A}$	$V_{GS} = 18\text{ V}$ , $T_{vj} = 25\text{ °C}$		8.1	12	mΩ
			$V_{GS} = 18\text{ V}$ , $T_{vj} = 125\text{ °C}$		13.1		
			$V_{GS} = 18\text{ V}$ , $T_{vj} = 175\text{ °C}$		17.4		
			$V_{GS} = 15\text{ V}$ , $T_{vj} = 25\text{ °C}$		9.7		
Gate threshold voltage	$V_{GS(th)}$	$I_D = 40\text{ mA}$ , $V_{DS} = V_{GS}$ , $T_{vj} = 25\text{ °C}$ , (tested after 1ms pulse at $V_{GS} = +20\text{ V}$ )	3.45	4.3	5.15	V	
Total gate charge	$Q_G$	$V_{DS} = 800\text{ V}$ , $V_{GS} = -3/18\text{ V}$		0.297		μC	
Internal gate resistor	$R_{Gint}$	$T_{vj} = 25\text{ °C}$		2.1		Ω	
Input capacitance	$C_{ISS}$	$f = 100\text{ kHz}$ , $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$		8.8		nF	
Output capacitance	$C_{OSS}$	$f = 100\text{ kHz}$ , $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$		0.42		nF	
Reverse transfer capacitance	$C_{rss}$	$f = 100\text{ kHz}$ , $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$		0.028		nF	
$C_{OSS}$ stored energy	$E_{OSS}$	$V_{DS} = 800\text{ V}$ , $V_{GS} = -3/18\text{ V}$ , $T_{vj} = 25\text{ °C}$		172		μJ	
Drain-source leakage current	$I_{DSS}$	$V_{DS} = 1200\text{ V}$ , $V_{GS} = -3\text{ V}$		0.06	380	μA	
Gate-source leakage current	$I_{GSS}$	$V_{DS} = 0\text{ V}$ , $T_{vj} = 25\text{ °C}$	$V_{GS} = 20\text{ V}$		400	nA	

**(table continues...)**

**Table 5** (continued) **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-on delay time (inductive load)	$t_{d\ on}$	$I_D = 100\ A, R_{Gon} = 15\ \Omega, V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	83		ns
			$T_{vj} = 125\ ^\circ C$	73		
			$T_{vj} = 175\ ^\circ C$	70		
Rise time (inductive load)	$t_r$	$I_D = 100\ A, R_{Gon} = 15\ \Omega, V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	106		ns
			$T_{vj} = 125\ ^\circ C$	111		
			$T_{vj} = 175\ ^\circ C$	116		
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 100\ A, R_{Goff} = 3.3\ \Omega, V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	74		ns
			$T_{vj} = 125\ ^\circ C$	80		
			$T_{vj} = 175\ ^\circ C$	84		
Fall time (inductive load)	$t_f$	$I_D = 100\ A, R_{Goff} = 3.3\ \Omega, V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	17		ns
			$T_{vj} = 125\ ^\circ C$	16		
			$T_{vj} = 175\ ^\circ C$	16		
Turn-on energy loss per pulse	$E_{on}$	$I_D = 100\ A, V_{DS} = 400\ V, L_\sigma = 27\ nH, V_{GS} = -3/18\ V, R_{Gon} = 15\ \Omega, di/dt = 2\ kA/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	3.28		mJ
			$T_{vj} = 125\ ^\circ C$	3.97		
			$T_{vj} = 175\ ^\circ C$	4.33		
Turn-off energy loss per pulse	$E_{off}$	$I_D = 100\ A, V_{DS} = 400\ V, L_\sigma = 27\ nH, V_{GS} = -3/18\ V, R_{Goff} = 3.3\ \Omega, dv/dt = 20.1\ kV/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	0.32		mJ
			$T_{vj} = 125\ ^\circ C$	0.38		
			$T_{vj} = 175\ ^\circ C$	0.42		
Thermal resistance, junction to heat sink	$R_{thJH}$	per MOSFET, Valid with IFX pre-applied Thermal Interface Material			0.581	K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		175	$^\circ C$

*Note: The selection of positive and negative gate-source voltages impacts the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Note AN 2018-09 must be considered to ensure sound operation of the device over the planned lifetime.*

*Tvj op > 150°C is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.*

### 3 Body diode

**Table 6** **Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
DC body diode forward current	$I_{SD}$	$T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V, T_H = 65\ ^\circ C$	32	A

**Table 7 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Forward voltage	$V_{SD}$	$I_{SD} = 100 \text{ A}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		4.2	5.35	V
			$T_{vj} = 125 \text{ }^\circ\text{C}$		3.9		
			$T_{vj} = 175 \text{ }^\circ\text{C}$		3.8		

## 4 IGBT, 3-Level

**Table 8 Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
Collector-emitter voltage	$V_{CES}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	650	V
Implemented collector current	$I_{CN}$		200	A
Continuous DC collector current	$I_{CDC}$	$T_{vj \text{ max}} = 175 \text{ }^\circ\text{C}$ $T_H = 65 \text{ }^\circ\text{C}$	90	A
Repetitive peak collector current	$I_{CRM}$	$t_p$ limited by $T_{vj \text{ op}}$	200	A
Gate-emitter peak voltage	$V_{GES}$		$\pm 20$	V

**Table 9 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Collector-emitter saturation voltage	$V_{CE \text{ sat}}$	$I_C = 100 \text{ A}, V_{GE} = 15 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	0.74	1.17	1.59	V
			$T_{vj} = 125 \text{ }^\circ\text{C}$		1.20		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		1.21		
Gate threshold voltage	$V_{Geth}$	$I_C = 2 \text{ mA}, V_{CE} = V_{GE}, T_{vj} = 25 \text{ }^\circ\text{C}$	3.25	4	4.75	V	
Gate charge	$Q_G$	$V_{GE} = \pm 15 \text{ V}, V_{CE} = 400 \text{ V}$		0.84		$\mu\text{C}$	
Internal gate resistor	$R_{Gint}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		0		$\Omega$	
Input capacitance	$C_{ies}$	$f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}$		14.3		nF	
Reverse transfer capacitance	$C_{res}$	$f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}$		0.05		nF	
Collector-emitter cut-off current	$I_{CES}$	$V_{CE} = 650 \text{ V}, V_{GE} = 0 \text{ V}$ $T_{vj} = 25 \text{ }^\circ\text{C}$			1	mA	
Gate-emitter leakage current	$I_{GES}$	$V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$			100	nA	
Turn-on delay time (inductive load)	$t_{don}$	$I_C = 100 \text{ A}, V_{CE} = 400 \text{ V}, V_{GE} = \pm 15 \text{ V}, R_{Gon} = 2.7 \text{ } \Omega$	$T_{vj} = 25 \text{ }^\circ\text{C}$		0.014		$\mu\text{s}$
			$T_{vj} = 125 \text{ }^\circ\text{C}$		0.015		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		0.015		

(table continues...)

**Table 9** (continued) **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rise time (inductive load)	$t_r$	$I_C = 100\text{ A}, V_{CE} = 400\text{ V}, V_{GE} = \pm 15\text{ V}, R_{Gon} = 2.7\ \Omega$	$T_{vj} = 25\text{ }^\circ\text{C}$	0.009		$\mu\text{s}$
			$T_{vj} = 125\text{ }^\circ\text{C}$	0.010		
			$T_{vj} = 150\text{ }^\circ\text{C}$	0.011		
Turn-off delay time (inductive load)	$t_{doff}$	$I_C = 100\text{ A}, V_{CE} = 400\text{ V}, V_{GE} = \pm 15\text{ V}, R_{Goff} = 39\ \Omega$	$T_{vj} = 25\text{ }^\circ\text{C}$	0.650		$\mu\text{s}$
			$T_{vj} = 125\text{ }^\circ\text{C}$	0.680		
			$T_{vj} = 150\text{ }^\circ\text{C}$	0.700		
Fall time (inductive load)	$t_f$	$I_C = 100\text{ A}, V_{CE} = 400\text{ V}, V_{GE} = \pm 15\text{ V}, R_{Goff} = 39\ \Omega$	$T_{vj} = 25\text{ }^\circ\text{C}$	0.023		$\mu\text{s}$
			$T_{vj} = 125\text{ }^\circ\text{C}$	0.045		
			$T_{vj} = 150\text{ }^\circ\text{C}$	0.055		
Turn-on energy loss per pulse	$E_{on}$	$I_C = 100\text{ A}, V_{CE} = 400\text{ V}, L_\sigma = 27\text{ nH}, V_{GE} = \pm 15\text{ V}, R_{Gon} = 2.7\ \Omega, di/dt = 7600\text{ A}/\mu\text{s} (T_{vj} = 150\text{ }^\circ\text{C})$	$T_{vj} = 25\text{ }^\circ\text{C}$	0.264		mJ
			$T_{vj} = 125\text{ }^\circ\text{C}$	0.394		
			$T_{vj} = 150\text{ }^\circ\text{C}$	0.438		
Turn-off energy loss per pulse	$E_{off}$	$I_C = 100\text{ A}, V_{CE} = 400\text{ V}, L_\sigma = 27\text{ nH}, V_{GE} = \pm 15\text{ V}, R_{Goff} = 39\ \Omega, dv/dt = 4800\text{ V}/\mu\text{s} (T_{vj} = 150\text{ }^\circ\text{C})$	$T_{vj} = 25\text{ }^\circ\text{C}$	1.7		mJ
			$T_{vj} = 125\text{ }^\circ\text{C}$	2.05		
			$T_{vj} = 150\text{ }^\circ\text{C}$	2.31		
Thermal resistance, junction to heat sink	$R_{thJH}$	per IGBT, Valid with IFX pre-applied Thermal Interface Material			0.723	K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		150	$^\circ\text{C}$

## 5 Diode, 3-Level

**Table 10** **Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj} = 25\text{ }^\circ\text{C}$	650	V	
Implemented forward current	$I_{FN}$		150	A	
Continuous DC forward current	$I_F$		100	A	
Repetitive peak forward current	$I_{FRM}$	$t_P = 1\text{ ms}$	200	A	
$I^2t$ - value	$I^2t$	$V_R = 0\text{ V}, t_P = 10\text{ ms}$	$T_{vj} = 125\text{ }^\circ\text{C}$	1270	$\text{A}^2\text{s}$
			$T_{vj} = 150\text{ }^\circ\text{C}$	1480	

**Table 11** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Forward voltage	$V_F$	$I_F = 100 \text{ A}, V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	0.74	1.35	1.86	V
			$T_{vj} = 125 \text{ }^\circ\text{C}$		1.29		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		1.25		
Peak reverse recovery current	$I_{RM}$	$I_F = 100 \text{ A}, V_R = 400 \text{ V}, V_{GE} = -15 \text{ V}, -di_F/dt = 2000 \text{ A}/\mu\text{s} (T_{vj} = 150 \text{ }^\circ\text{C})$	$T_{vj} = 25 \text{ }^\circ\text{C}$		64.2		A
			$T_{vj} = 125 \text{ }^\circ\text{C}$		99.8		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		114		
Recovered charge	$Q_r$	$I_F = 100 \text{ A}, V_R = 400 \text{ V}, V_{GE} = -15 \text{ V}, -di_F/dt = 2000 \text{ A}/\mu\text{s} (T_{vj} = 150 \text{ }^\circ\text{C})$	$T_{vj} = 25 \text{ }^\circ\text{C}$		3.99		$\mu\text{C}$
			$T_{vj} = 125 \text{ }^\circ\text{C}$		7.07		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		9.8		
Reverse recovery energy	$E_{rec}$	$I_F = 100 \text{ A}, V_R = 400 \text{ V}, V_{GE} = -15 \text{ V}, -di_F/dt = 2000 \text{ A}/\mu\text{s} (T_{vj} = 150 \text{ }^\circ\text{C})$	$T_{vj} = 25 \text{ }^\circ\text{C}$		0.45		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$		1		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		1.35		
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode, Valid with IFX pre-applied Thermal Interface Material			0.802	K/W	
Temperature under switching conditions	$T_{vj op}$		-40		150	$^\circ\text{C}$	

## 6 NTC-Thermistor

**Table 12** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	$R_{25}$	$T_{NTC} = 25 \text{ }^\circ\text{C}$		5		k $\Omega$
Deviation of $R_{100}$	$\Delta R/R$	$T_{NTC} = 100 \text{ }^\circ\text{C}, R_{100} = 493 \text{ } \Omega$	-5		5	%
Power dissipation	$P_{25}$	$T_{NTC} = 25 \text{ }^\circ\text{C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

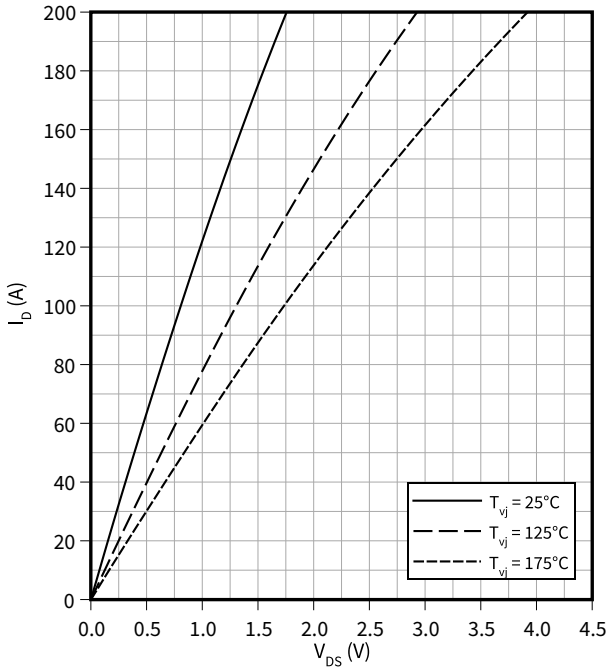
Note: Specification according to the valid application note.



## 7 Characteristics diagrams

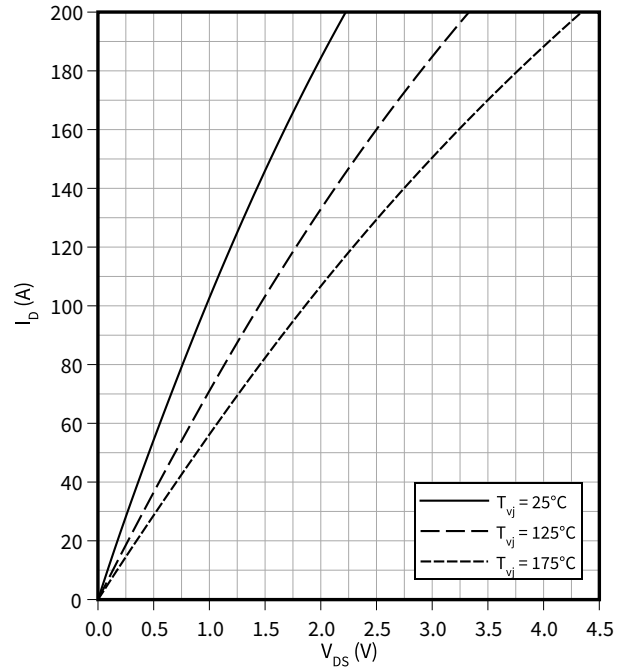
**output characteristic (typical), MOSFET**

$I_D = f(V_{DS})$   
 $V_{GS} = 18\text{ V}$



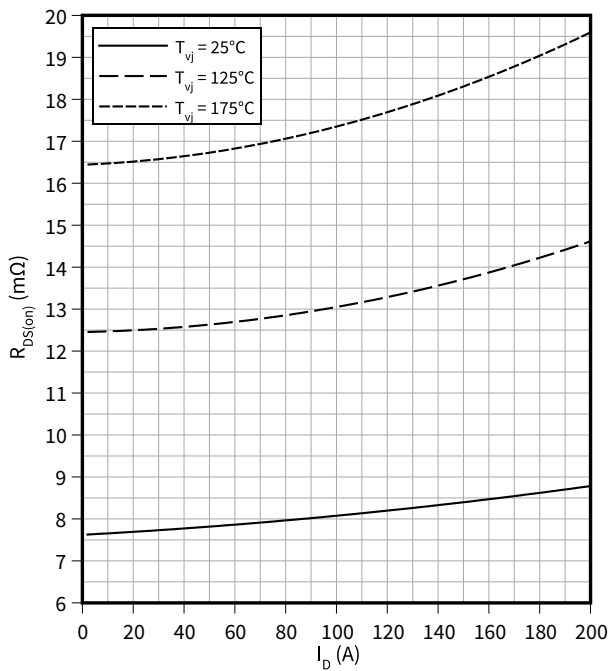
**output characteristic (typical), MOSFET**

$I_D = f(V_{DS})$   
 $V_{GS} = 15\text{ V}$



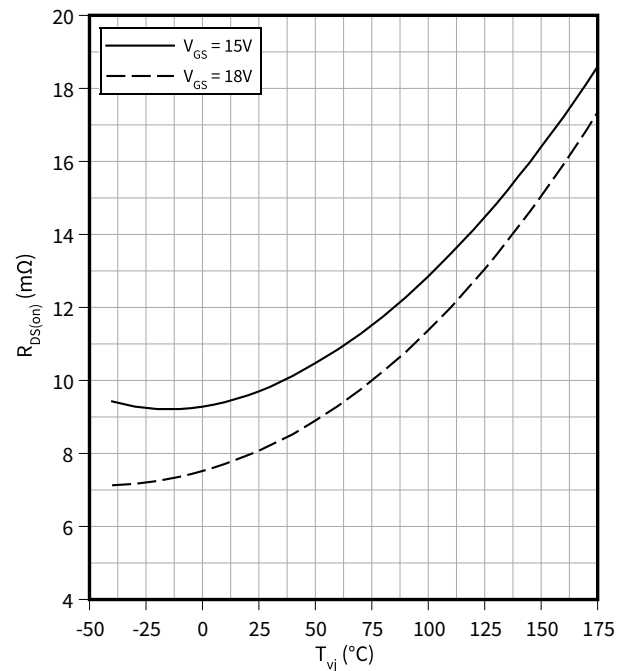
**Drain source on-resistance (typical), MOSFET**

$R_{DS(on)} = f(I_D)$   
 $V_{GS} = 18\text{ V}$



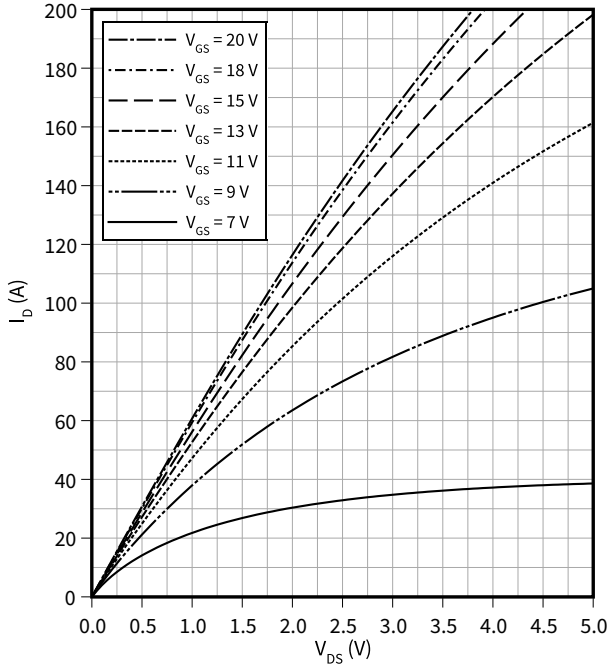
**Drain source on-resistance (typical), MOSFET**

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 100\text{ A}$



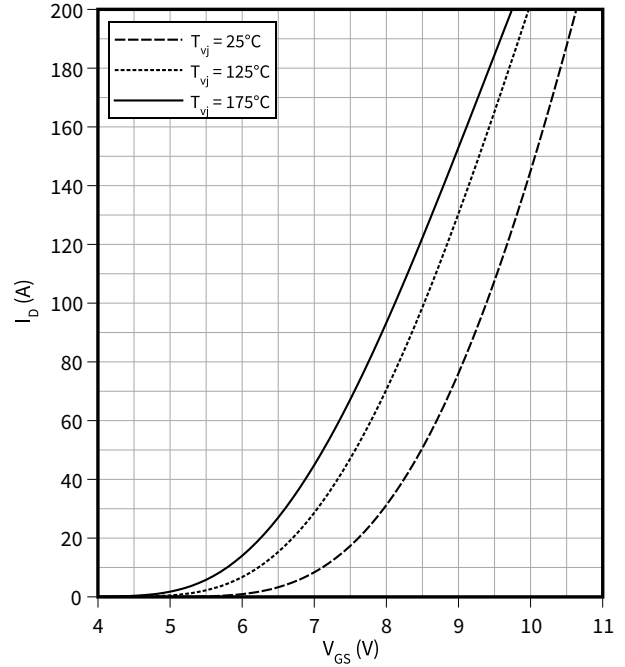
**Output characteristic field (typical), MOSFET**

$I_D = f(V_{DS})$   
 $T_{vj} = 175\text{ °C}$



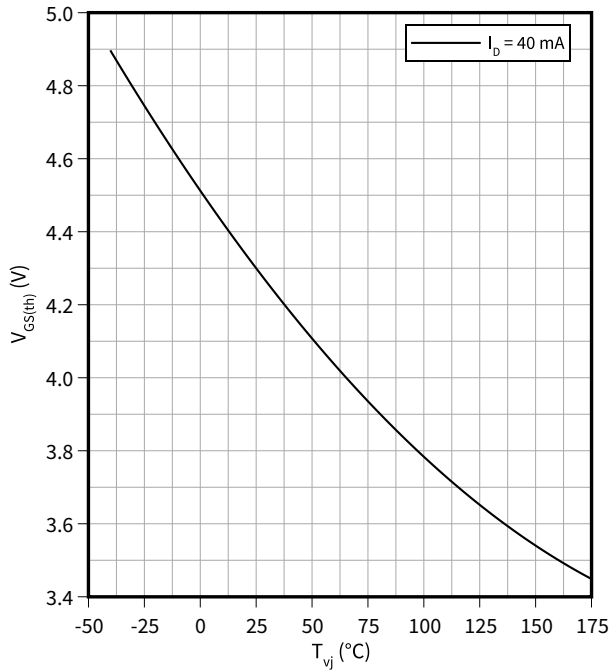
**Transfer characteristic (typical), MOSFET**

$I_D = f(V_{GS})$   
 $V_{DS} = 20\text{ V}$



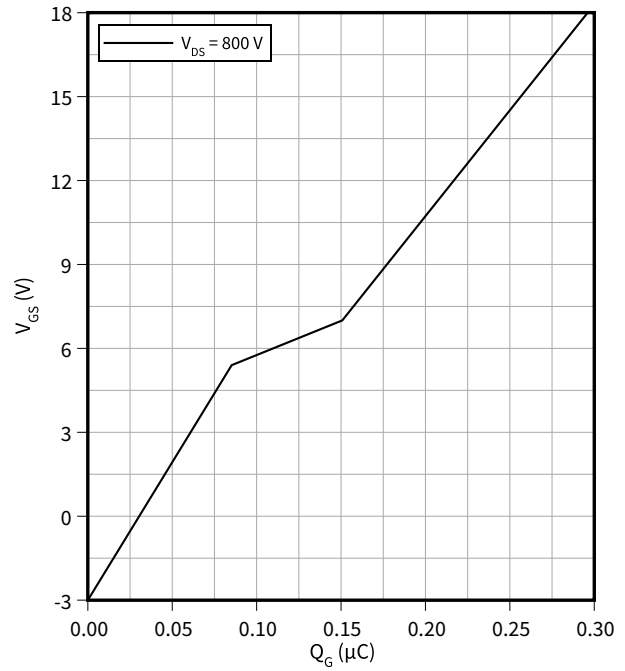
**Gate-source threshold voltage (typical), MOSFET**

$V_{GS(th)} = f(T_{vj})$   
 $V_{GS} = V_{DS}$



**Gate charge characteristic (typical), MOSFET**

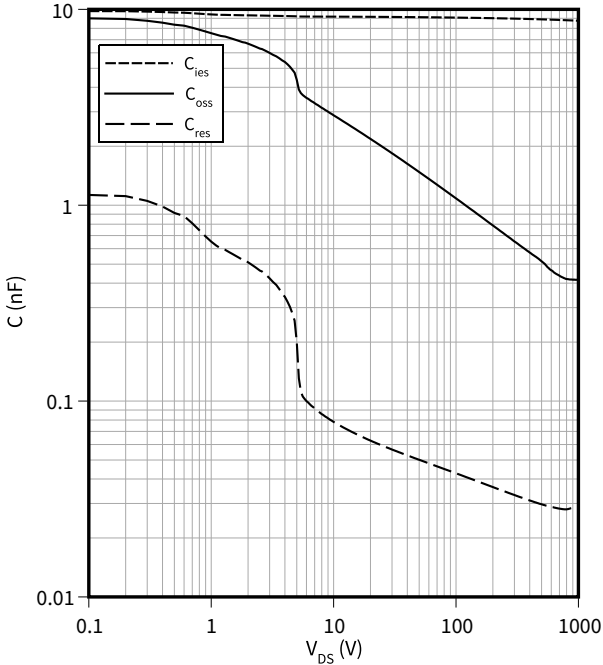
$V_{GS} = f(Q_G)$   
 $I_D = 100\text{ A}, T_{vj} = 25\text{ °C}$



7 Characteristics diagrams

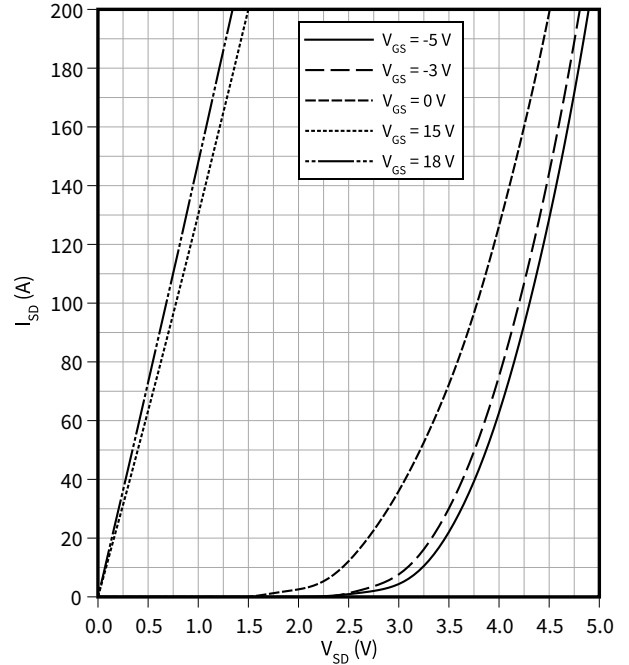
**Capacity characteristic (typical), MOSFET**

$C = f(V_{DS})$   
 $f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{GS} = 0 \text{ V}$



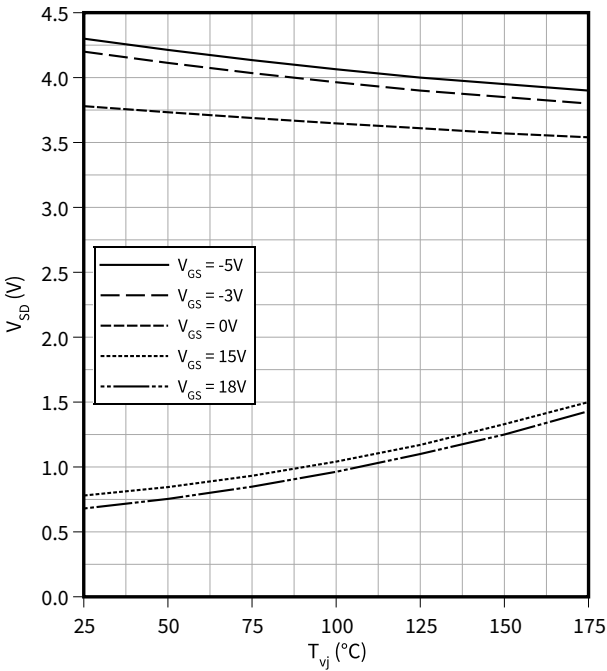
**Forward characteristic body diode (typical), MOSFET**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 25 \text{ }^\circ\text{C}$



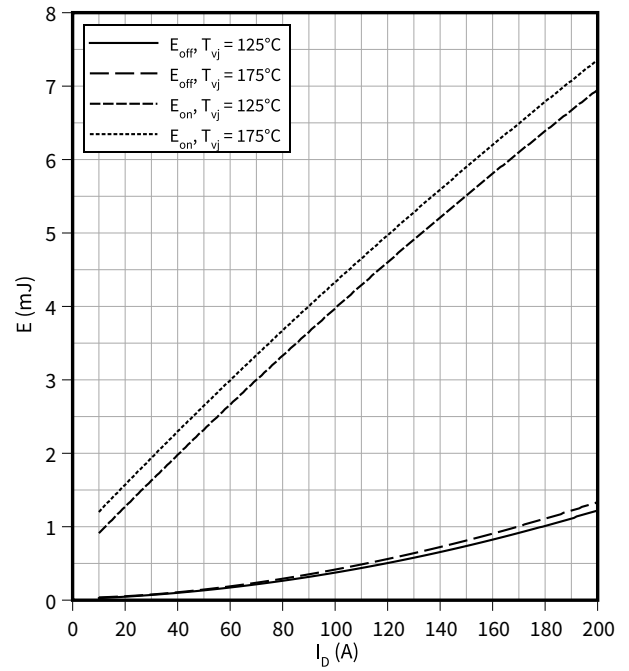
**Forward voltage of body diode (typical), MOSFET**

$V_{SD} = f(T_{vj})$   
 $I_{SD} = 100 \text{ A}$



**Switching losses (typical), MOSFET**

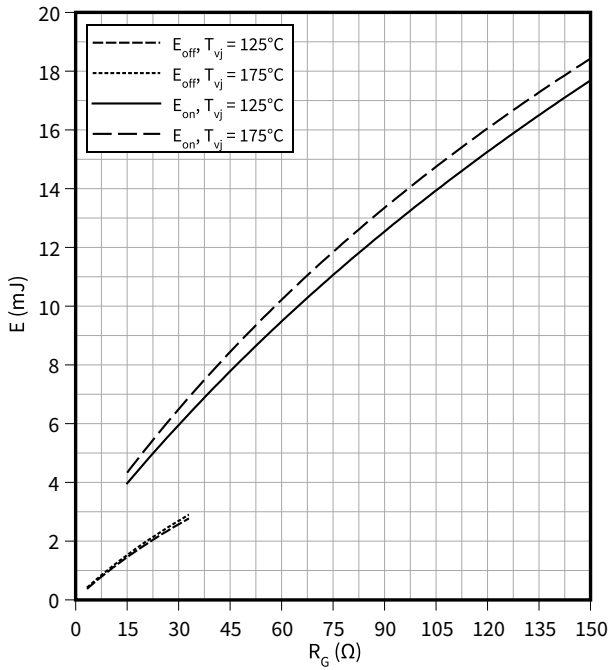
$E = f(I_D)$   
 $R_{Goff} = 3.3 \text{ } \Omega, R_{Gon} = 15 \text{ } \Omega, V_{DS} = 400 \text{ V}, V_{GS} = -3/18 \text{ V}$



**Switching losses (typical), MOSFET**

$E = f(R_G)$

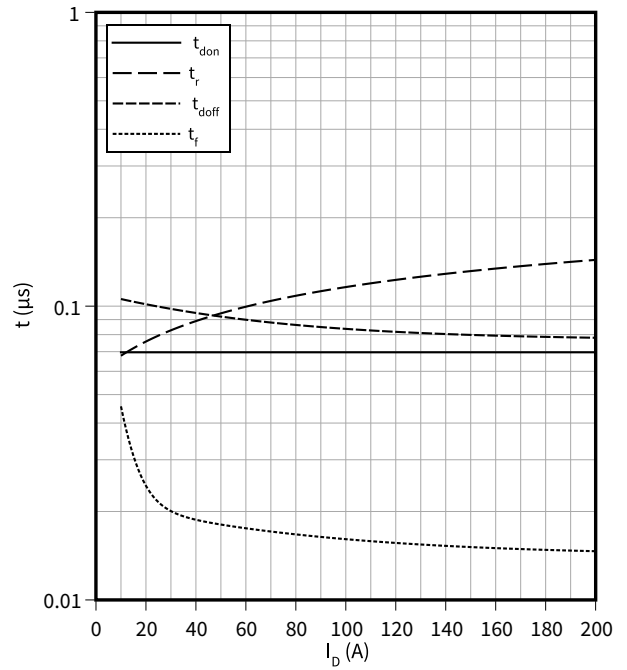
$V_{DS} = 400 \text{ V}, I_D = 100 \text{ A}, V_{GS} = -3/18 \text{ V}$



**Switching times (typical), MOSFET**

$t = f(I_D)$

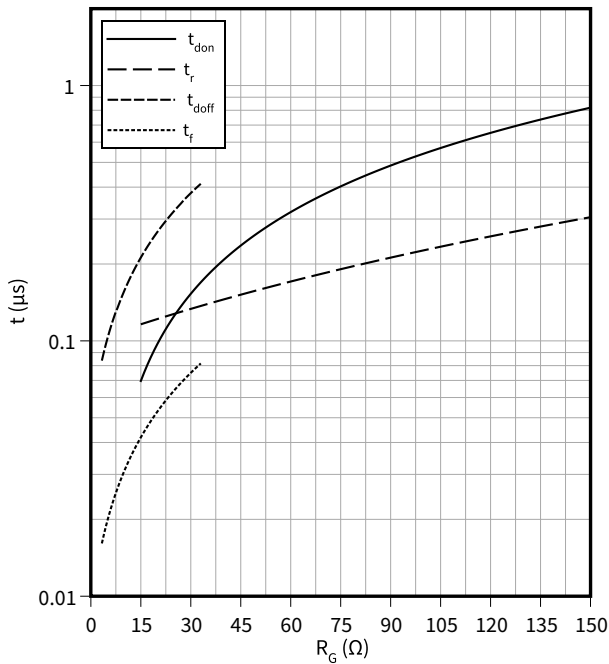
$R_{Goff} = 3.3 \text{ } \Omega, R_{Gon} = 15 \text{ } \Omega, V_{DS} = 400 \text{ V}, T_{vj} = 175 \text{ } ^\circ\text{C}, V_{GS} = -3/18 \text{ V}$



**Switching times (typical), MOSFET**

$t = f(R_G)$

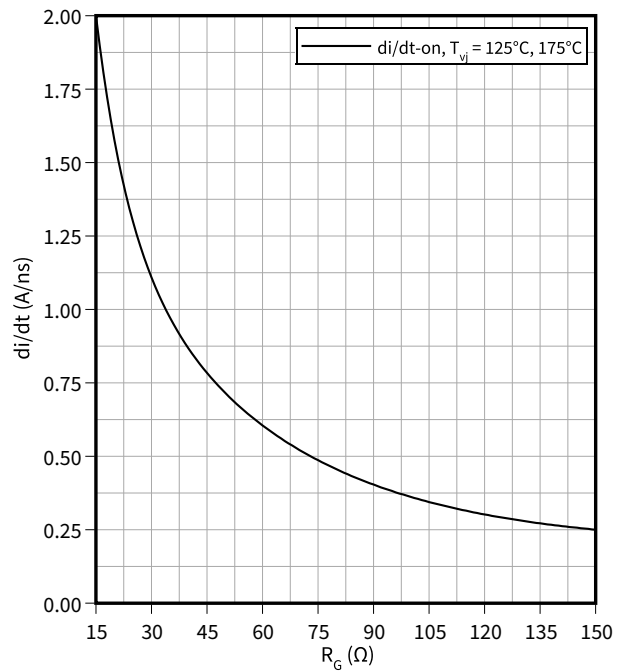
$V_{DS} = 400 \text{ V}, I_D = 100 \text{ A}, T_{vj} = 175 \text{ } ^\circ\text{C}, V_{GS} = -3/18 \text{ V}$



**Current slope (typical), MOSFET**

$di/dt = f(R_G)$

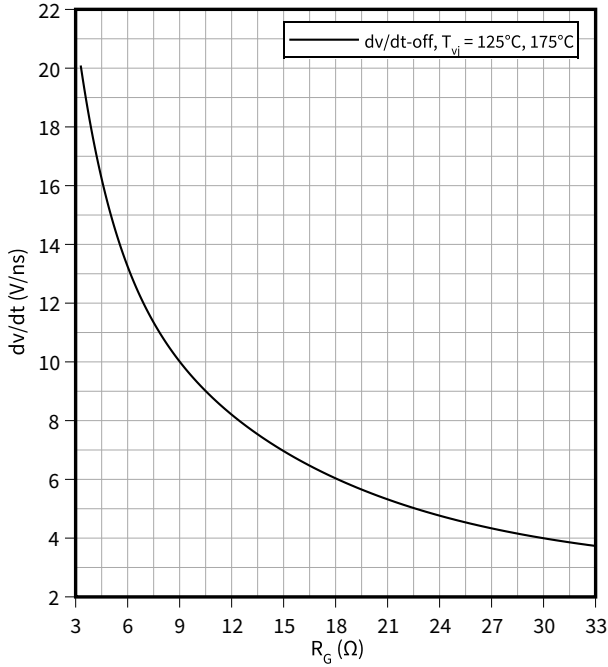
$V_{DS} = 400 \text{ V}, I_D = 100 \text{ A}, V_{GS} = -3/18 \text{ V}$



**Voltage slope (typical), MOSFET**

$dv/dt = f(R_G)$

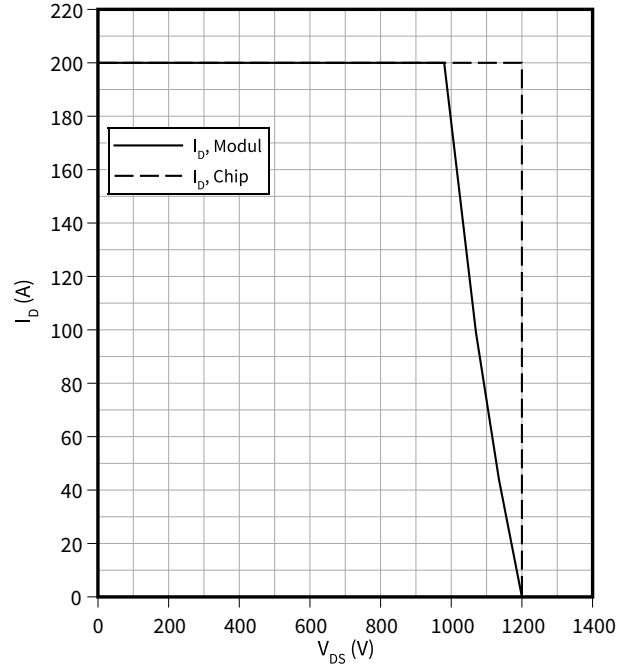
$V_{DS} = 400\text{ V}$ ,  $I_D = 100\text{ A}$ ,  $V_{GS} = -3/18\text{ V}$



**Reverse bias safe operating area (RBSOA), MOSFET**

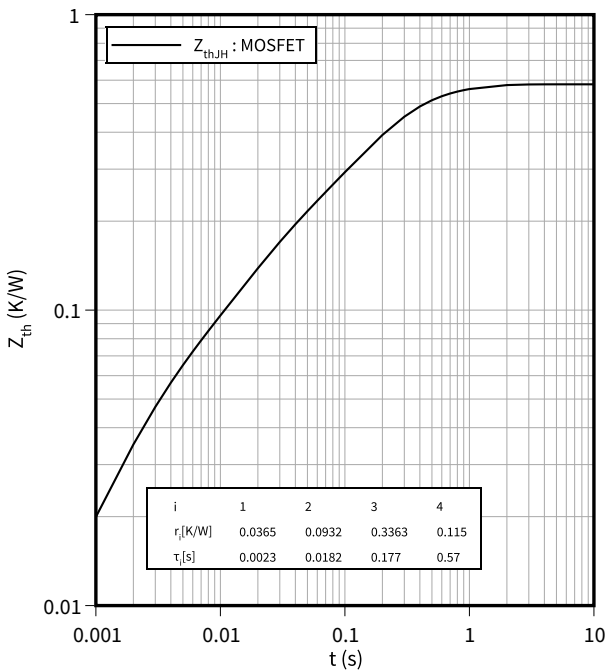
$I_D = f(V_{DS})$

$R_{Goff} = 3.3\ \Omega$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{GS} = -3/18\text{ V}$



**Transient thermal impedance, MOSFET**

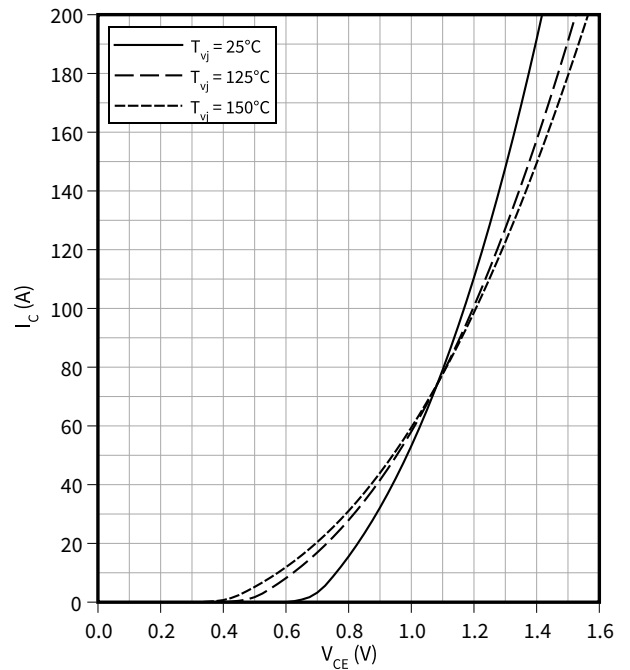
$Z_{th} = f(t)$



**Output characteristic (typical), IGBT, 3-Level**

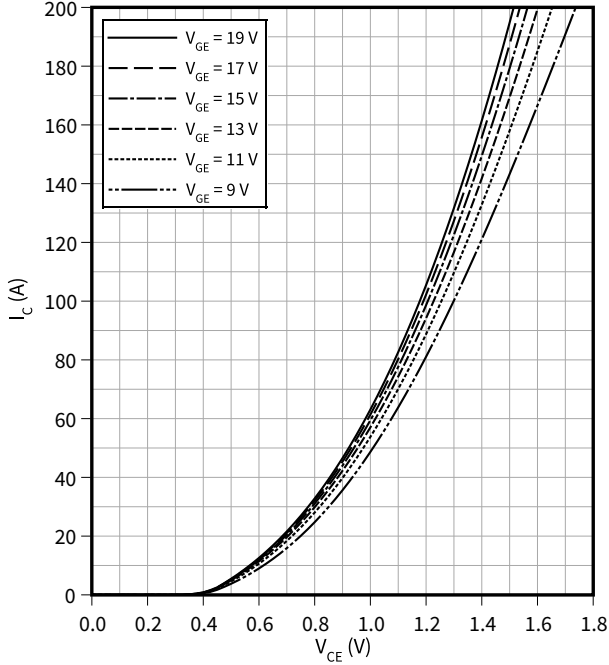
$I_C = f(V_{CE})$

$V_{GE} = 15\text{ V}$



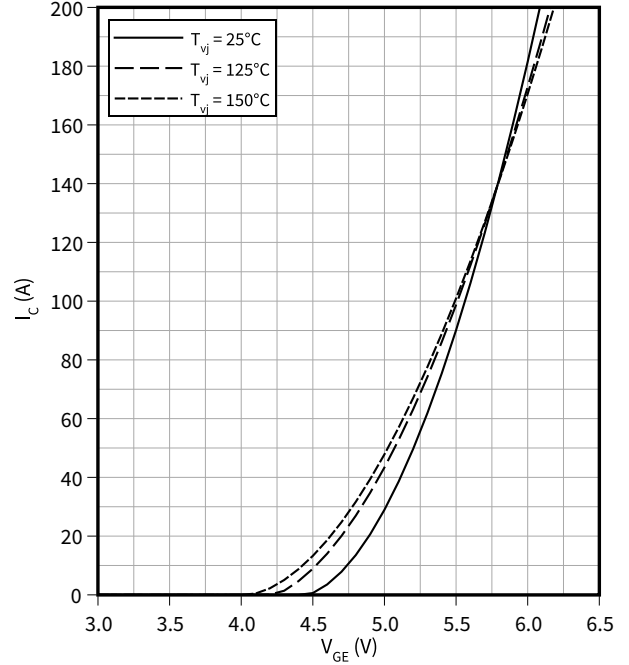
**Output characteristic field (typical), IGBT, 3-Level**

$I_C = f(V_{CE})$   
 $T_{vj} = 150\text{ °C}$



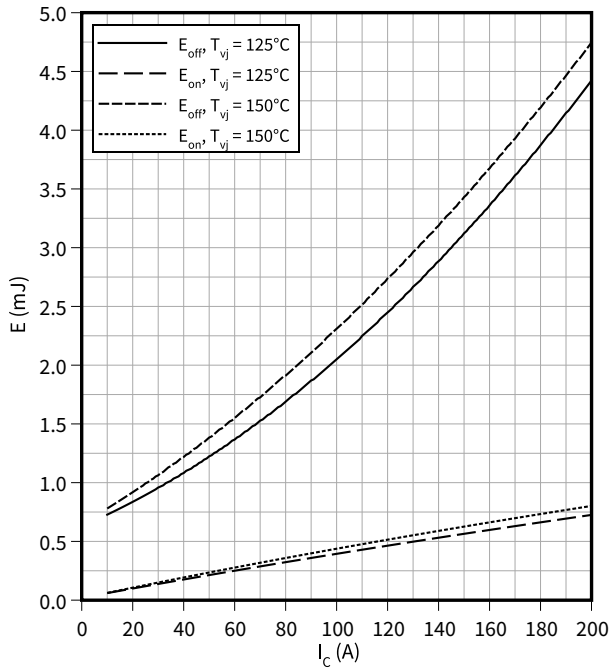
**Transfer characteristic (typical), IGBT, 3-Level**

$I_C = f(V_{GE})$   
 $V_{CE} = 20\text{ V}$



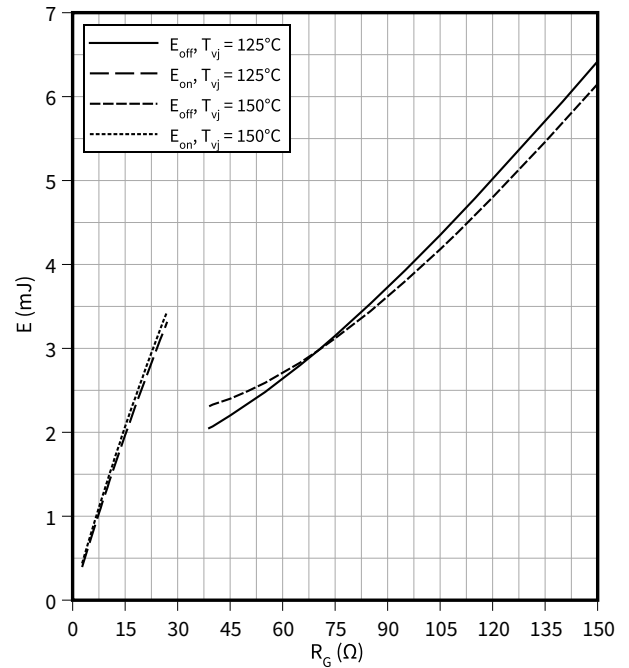
**Switching losses (typical), IGBT, 3-Level**

$E = f(I_C)$   
 $R_{Goff} = 39\ \Omega$ ,  $R_{Gon} = 2.7\ \Omega$ ,  $V_{CE} = 400\text{ V}$ ,  $V_{GE} = -15 / +15\text{ V}$



**Switching losses (typical), IGBT, 3-Level**

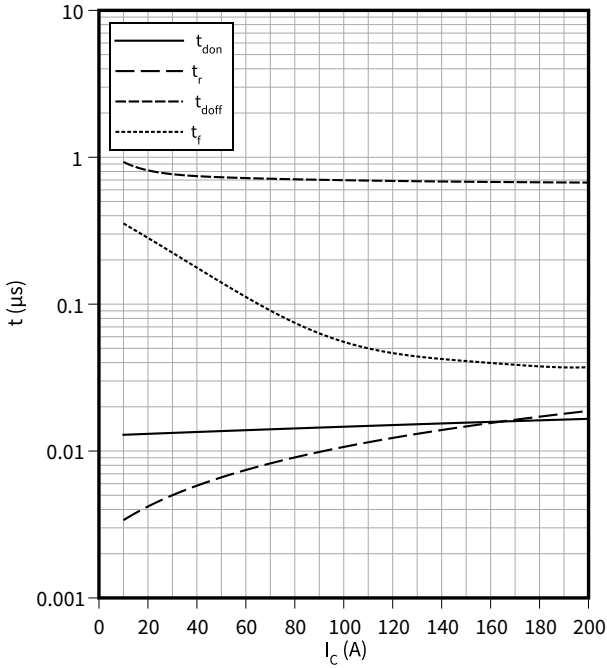
$E = f(R_G)$   
 $I_C = 100\text{ A}$ ,  $V_{CE} = 400\text{ V}$ ,  $V_{GE} = -15 / +15\text{ V}$



**Switching times (typical), IGBT, 3-Level**

$t = f(I_C)$

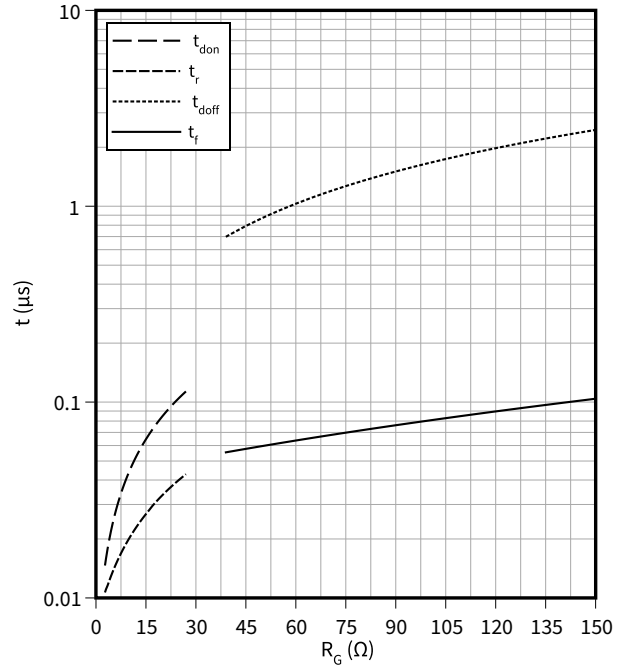
$R_{Goff} = 39 \Omega$ ,  $R_{Gon} = 2.7 \Omega$ ,  $R_{Gon} = 2.7 \Omega$ ,  $V_{CE} = 400 \text{ V}$ ,  $V_{GE} = \pm 15 \text{ V}$ ,  $T_{vj} = 150 \text{ }^\circ\text{C}$



**Switching times (typical), IGBT, 3-Level**

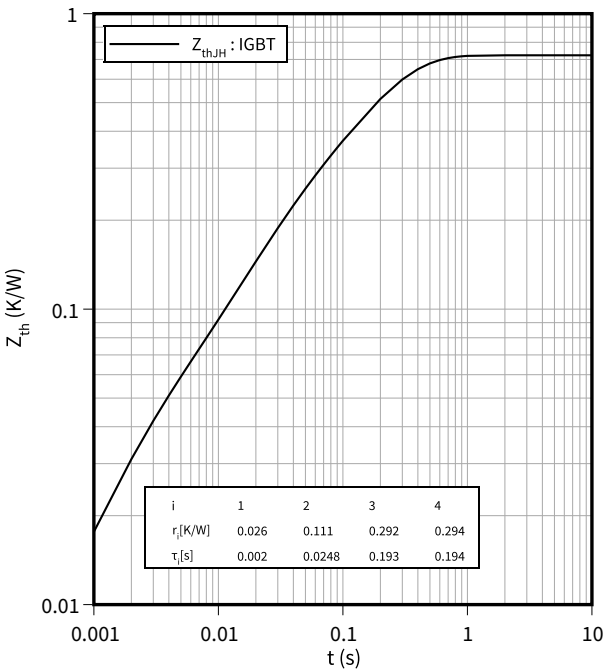
$t = f(R_G)$

$I_C = 100 \text{ A}$ ,  $V_{CE} = 400 \text{ V}$ ,  $V_{GE} = -15 / +15 \text{ V}$ ,  $T_{vj} = 150 \text{ }^\circ\text{C}$



**Transient thermal impedance, IGBT, 3-Level**

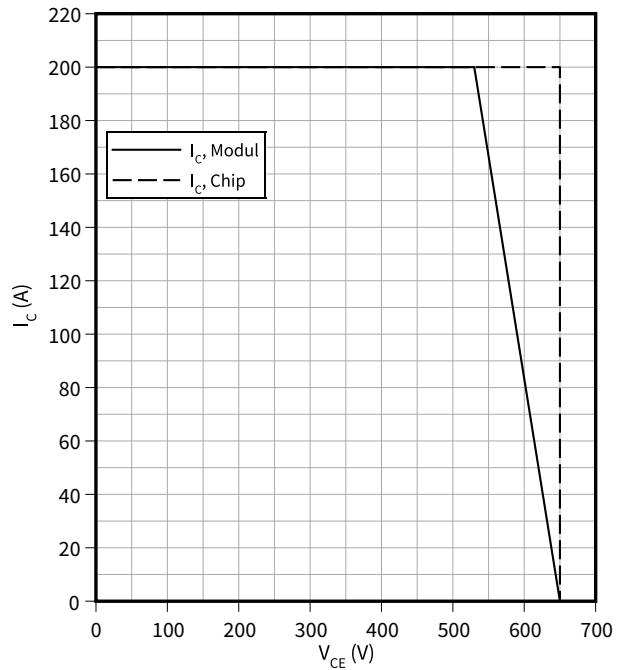
$Z_{th} = f(t)$



**Reverse bias safe operating area (RBSOA), IGBT, 3-Level**

$I_C = f(V_{CE})$

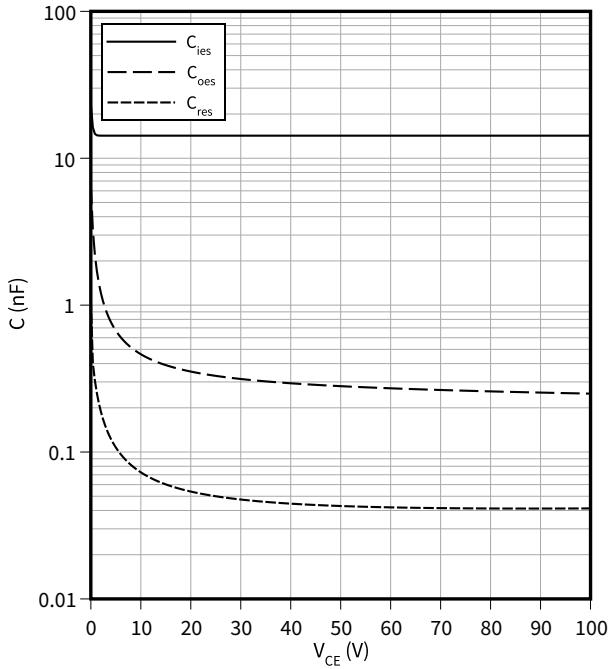
$T_{vj} = 150 \text{ }^\circ\text{C}$ ,  $R_{Goff} = 39 \Omega$ ,  $V_{GE} = \pm 15 \text{ V}$



7 Characteristics diagrams

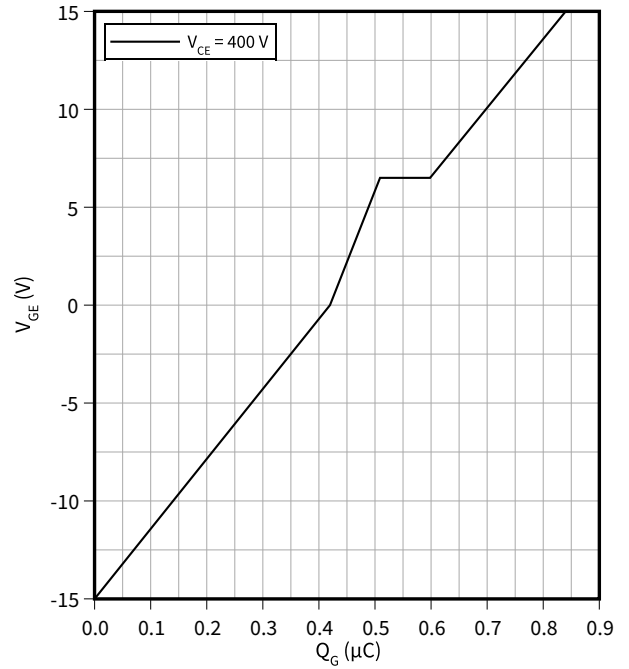
**Capacity characteristic (typical), IGBT, 3-Level**

$C = f(V_{CE})$   
 $f = 100 \text{ kHz}, V_{GE} = 0 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$



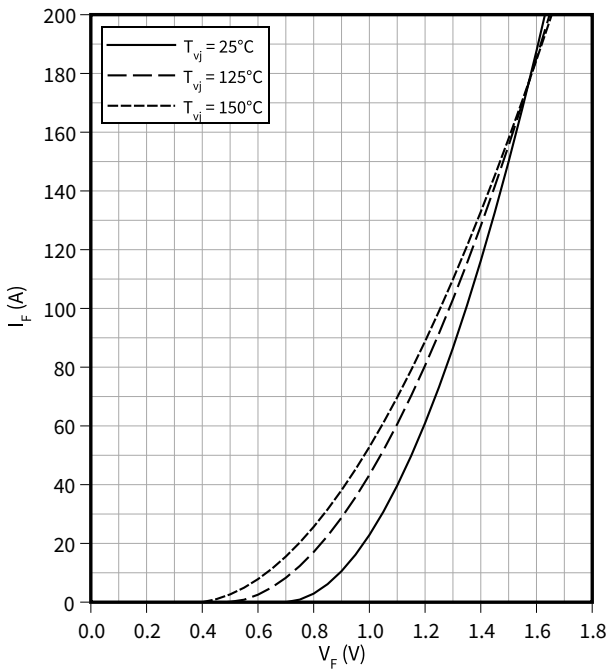
**Gate charge characteristic (typical), IGBT, 3-Level**

$V_{GE} = f(Q_G)$   
 $I_C = 100 \text{ A}, T_{vj} = 25 \text{ }^\circ\text{C}$



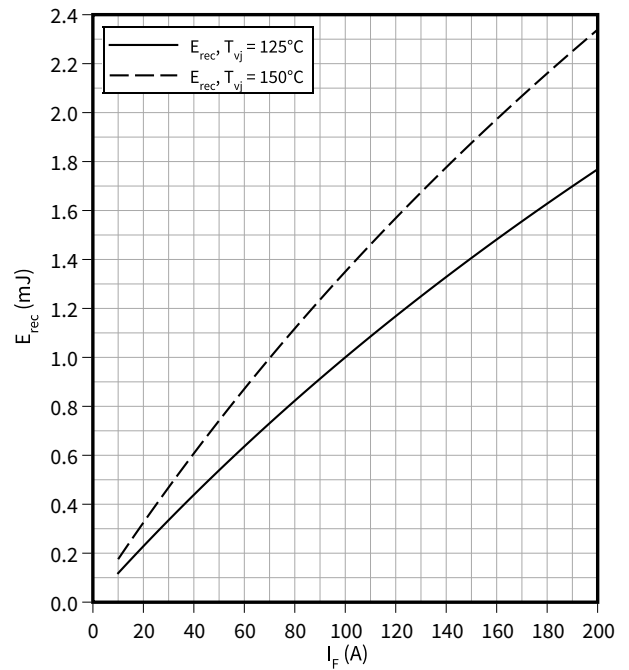
**Forward characteristic (typical), Diode, 3-Level**

$I_F = f(V_F)$



**Switching losses (typical), Diode, 3-Level**

$E_{rec} = f(I_F)$   
 $R_G = 15 \text{ } \Omega, V_R = 400 \text{ V}$

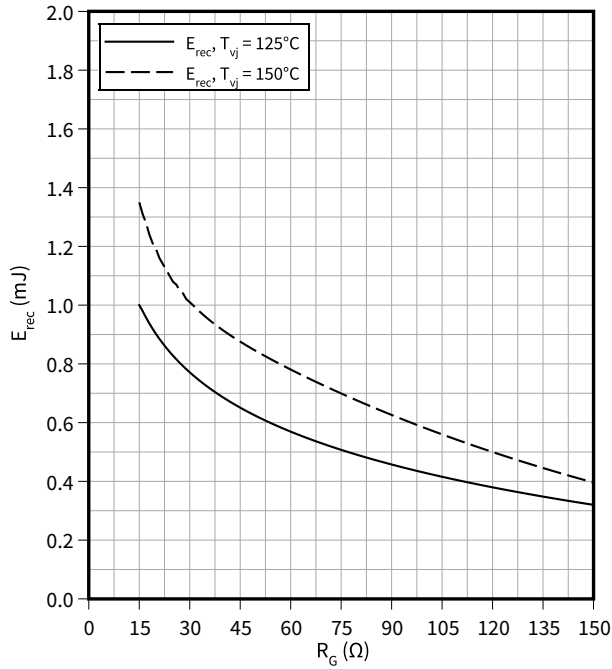




**Switching losses (typical), Diode, 3-Level**

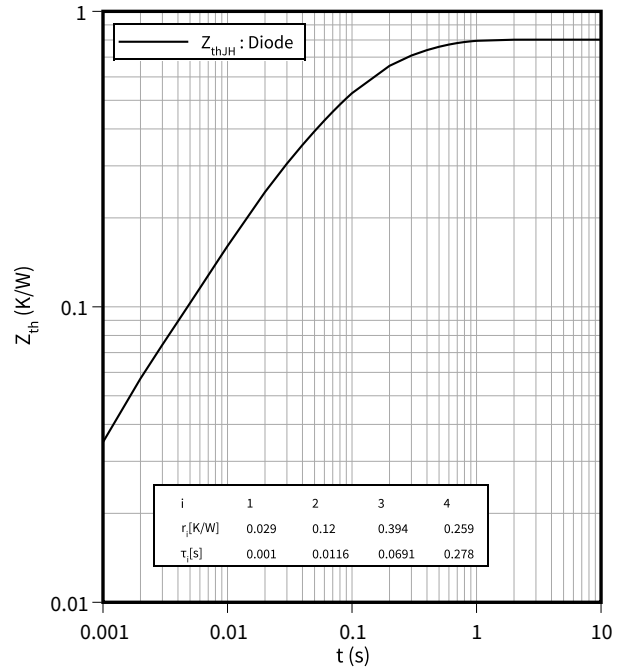
$E_{rec} = f(R_G)$

$I_F = 100\text{ A}, V_R = 400\text{ V}$



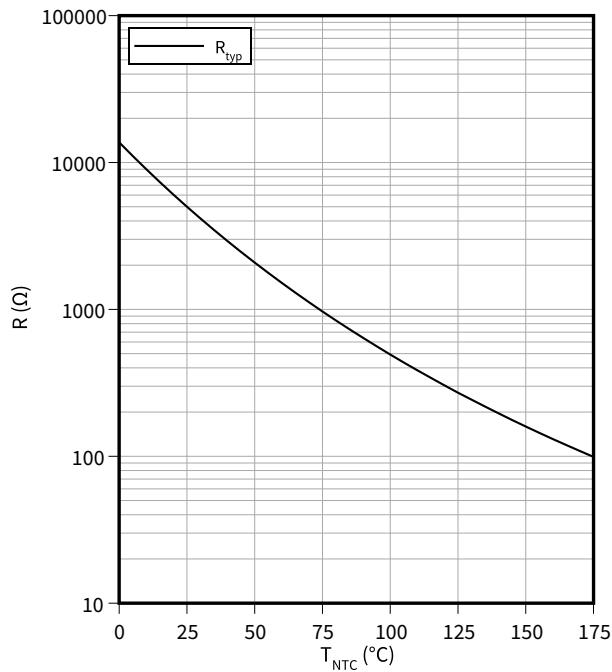
**Transient thermal impedance, Diode, 3-Level**

$Z_{th} = f(t)$



**Temperature characteristic (typical), NTC-Thermistor**

$R = f(T_{NTC})$



## 8 Circuit diagram

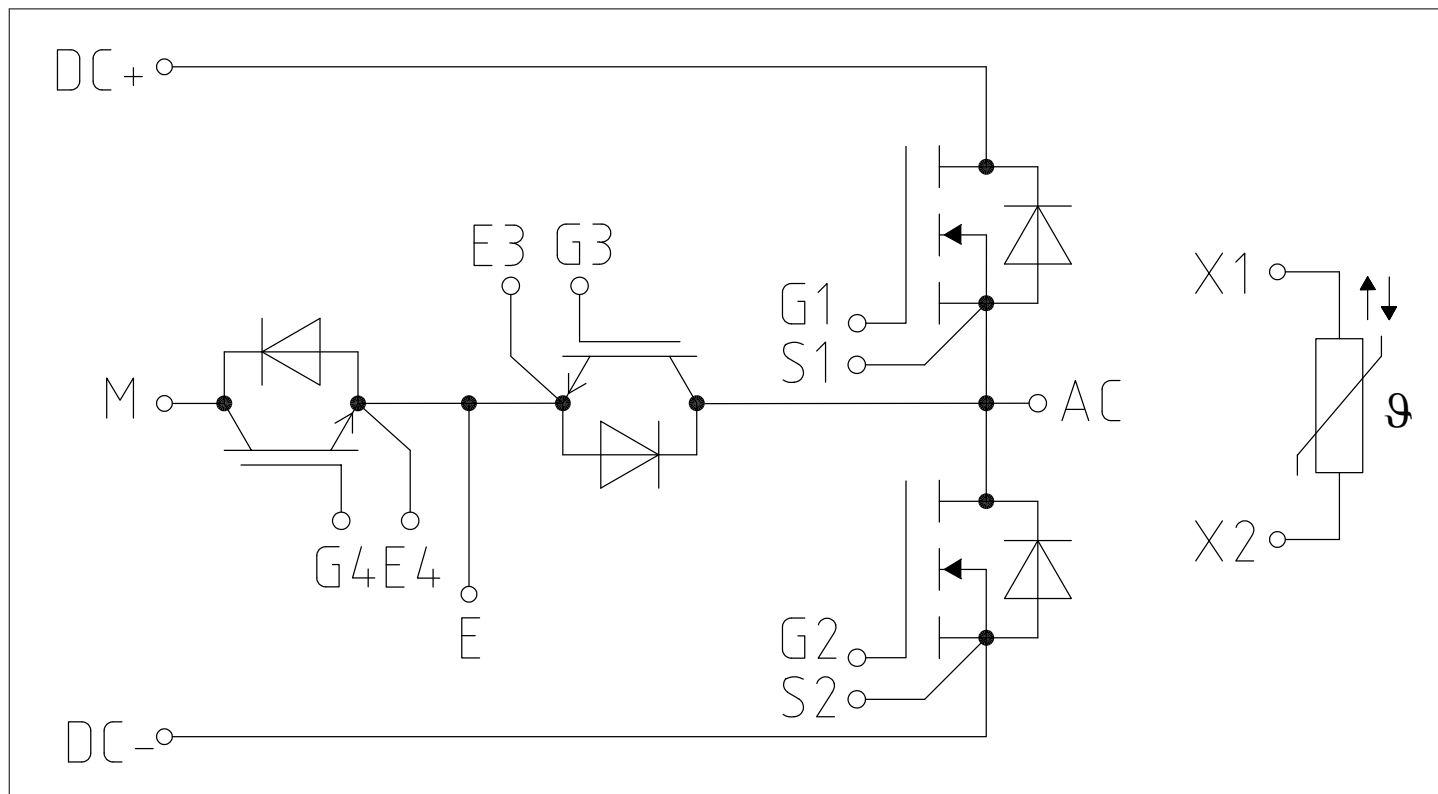


Figure 1

9 Package outlines

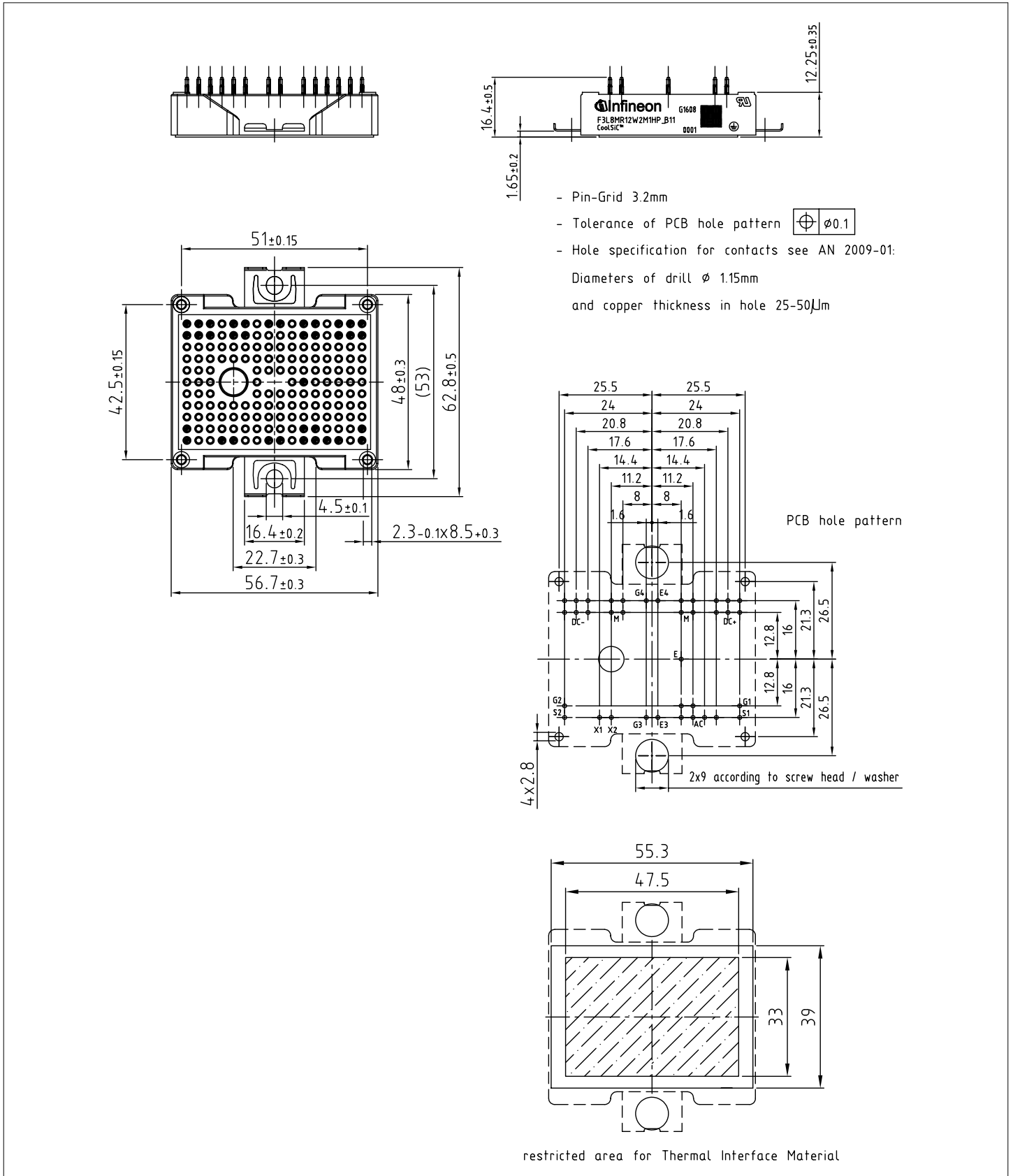

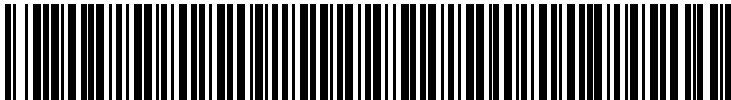


Figure 2

## 10 Module label code

Module label code			
Code format	Data Matrix	Barcode Code128	
Encoding	ASCII text	Code Set A	
Symbol size	16x16	23 digits	
Standard	IEC24720 and IEC16022	IEC8859-1	
Code content	<i>Content</i>	<i>Digit</i>	<i>Example</i>
	Module serial number	1 - 5	71549
	Module material number	6 - 11	142846
	Production order number	12 - 19	55054991
	Date code (production year)	20 - 21	15
	Date code (production week)	22 - 23	30
Example	 		
	71549142846550549911530		71549142846550549911530

**Figure 3**

## Revision history

Document revision	Date of release	Description of changes
0.10	2021-04-07	
1.00	2022-03-09	Final datasheet
1.10	2022-03-10	Final datasheet